

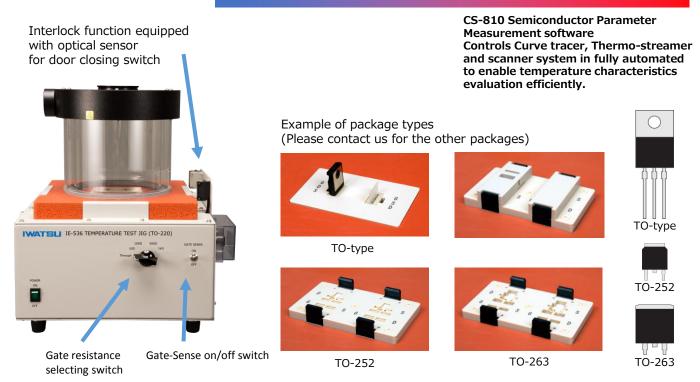
## **Temperature Characteristics Measurement Option**



For High speed characterization on semiconductor devices at wide temperature range



## Full automatic temperature characteristics measurement

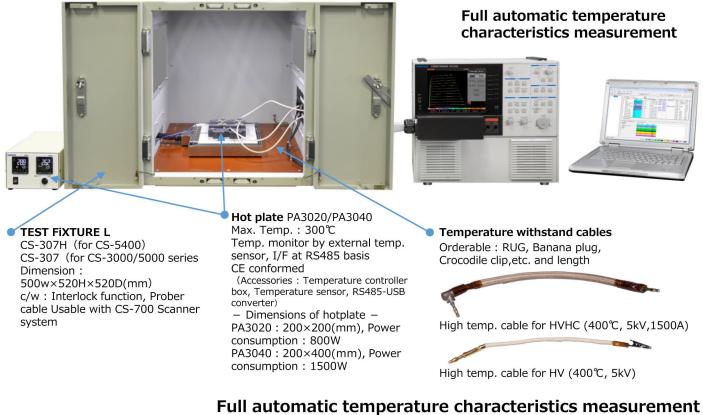


Temperature Test JIG for TO type packages

Room Temp.

## Hotplate system for room temperature to 400°C

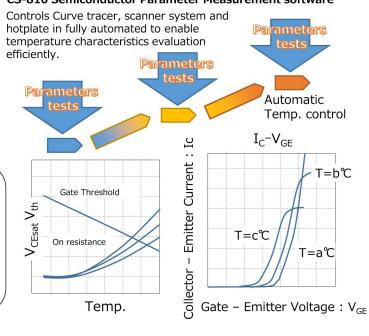
Recommended for Room temperature to high temperature characterization with hotplate system



Connection example in Fixture(prober cable : CS-307)



CS-810 Semiconductor Parameter Measurement software



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High Temp.

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devices

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